# Notice of References Cited Application/Control No. 10/580,953 Examiner TABASSOM TADAYYON Applicant(s)/Patent Under Reexamination KANO ET AL. Page 1 of 2

# **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/02357 <b>8</b> 5	12-2003	Barclay et al.	430/271.1
	В	US-			
	O	US-			
	D	US-			
	ш	US-			
	F	US-			
	G	US-			
	Ι	US-		1	
	-	US-			
	_	US-			
	K	US-			
	L	US-			
	М	US-			

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2003-332738	11-2003	qį	Wakizaka et al	
	0					
	Р					
	a					
9	R					
	s					
	I			Level La Sale		

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	J	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. 10/580,953 Examiner TABASSOM TADAYYON Applicant(s)/Patent Under Reexamination KANO ET AL. Page 2 of 2

# **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	O	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Ι	US-			
	ı	US-			
	J	US-			
	K	US-			
	<del>ا</del> ۔	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
М,	Р					
	a					
	R					
	s					
	Т					

### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.